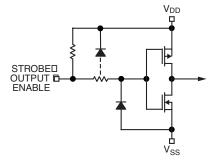
### **Typical Input Circuits**



#### **Absolute Maximum Ratings (Note 1)**

at 25°C Free-Air Temperature and VSS = 0V

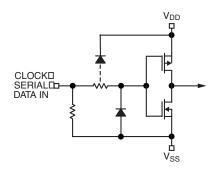
Output Voltage, VCF 50V (MIC5821) (MIC5822) 80V Output Voltage, V<sub>CE SUS</sub> (MIC5821)(Note 3) 35V (MIC5822)(Note 3) 50V Logic Supply Voltage, VDD 15V Input Voltage Range, VIN -0.3V to  $V_{DD} + 0.3V$  $V_{DD} - V_{EE}$ 25V Emitter Supply Voltage, VEE -20V Continuous Output Current, IOUT 500mA Package Power Dissipation, P<sub>D(Note 1)</sub> 1.67W Operating Temperature Range, TA -55°C to +85°C Storage Temperature Range, TS -65°C to +150°C

Note 1: Derate at the rate of 16.7mW/ $^{\circ}$ C above  $T_A = 25^{\circ}$ C.

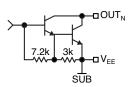
Note 2: CMOS devices have input static protection but are susceptible to damage when exposed to extremely high static electrical charges.

Note 3: For inductive load applications.

Note 4: Specification for packaged product only.



## **Typical Output Driver**



## Maximum Allowable Duty Cycle (Plastic DIP)

Number of Outputs ON (I <sub>OUT</sub> = 200mA	Maximum Allowable Duty Cycle at Ambient Temperature of									
V <sub>DD</sub> = 12V)	25°C	40°C	50°C	60°C	70°C					
8	73%	62%	55%	47%	40%					
7	83%	71%	62%	54%	46%					
6	97%	82%	72%	63%	53%					
5	100%	98%	87%	75%	63%					
4	100%	100%	100%	93%	79%					
3	100%	100%	100%	100%	100%					
2	100%	100%	100%	100%	100%					
1	100%	100%	100%	100%	100%					

# Electrical Characteristics (Note 4) at $T_A = 25^{\circ}\text{C V}_{DD} = 5\text{V}$ , $V_{EE} = V_{SS} = 0\text{V}$ (unless otherwise specified)

		Applicable			Limits	
Characteristic	Symbol	Devices	Test Conditions	Min.	Max.	Unit
Output Leakage Current	I <sub>CEX</sub>	MIC5821	V <sub>OUT</sub> = 50V		50	μΑ
			$V_{OUT} = 50V, T_A = +70^{\circ}C$		100	
		MIC5822	V <sub>OUT</sub> = 80V		50	
			$V_{OUT} = 80V, T_A = +70^{\circ}C$		100	
Collector-Emitter	V <sub>CE(SAT)</sub>	Both	I <sub>OUT</sub> = 100mA		1.1	V
Saturation Voltage			I <sub>OUT</sub> = 200mA		1.3	
			I <sub>OUT</sub> = 350mA, V <sub>DD</sub> = 7.0V		1.6	
Input Voltage	V <sub>IN(0)</sub>	Both			0.8	V
	V <sub>IN(1)</sub>	Both	V <sub>DD</sub> = 12V	10.5		
			V <sub>DD</sub> = 10V	8.5		
			V <sub>DD</sub> = 5.0V	3.5		
Input Resistance	R <sub>IN</sub>	Both	V <sub>DD</sub> = 12V	50		kΩ
			V <sub>DD</sub> = 10V	50		
			V <sub>DD</sub> = 5.0V	50		
Supply Current	I <sub>DD(ON)</sub>	Both	One Driver ON, V <sub>DD</sub> = 12V		4.5	mA
			One Driver ON, V <sub>DD</sub> = 10V		3.9	
			One Driver ON, V <sub>DD</sub> = 5.0V		2.4	
			All Drivers ON, V <sub>DD</sub> = 12V		16	
			All Drivers ON, V <sub>DD</sub> = 10V		14	
			All Drivers ON, V <sub>DD</sub> = 5.0V		8	
	IDD(OFF)	Both	All Drivers OFF, V <sub>DD</sub> = 5.0V, All Inputs = 0V		1.6	
			All Drivers OFF, V <sub>DD</sub> = 12V, All Inputs= 0V		2.9	

# **Electrical Characteristics (Note 4)** $T_A = -55^{\circ}C$ , $V_{DD} = 5V$ , $V_{SS} = V_{EE} = 0V$ (unless otherwise noted)

			Limits			
Characteristic	Symbol	Test Conditions	Min.	Max.	Unit	
Output Leakage Current	I <sub>CEX</sub>	V <sub>OUT</sub> = 80V		50	μА	
Collector-Emitter	V <sub>CE(SAT)</sub>	I <sub>OUT</sub> = 100mA		1.3	V	
Saturation Voltage		I <sub>OUT</sub> = 200mA		1.5	]	
		$I_{OUT} = 350 \text{mA}, V_{DD} = 7.0 \text{V}$		1.8	1	
Input Voltage	V <sub>INO)</sub>			0.8	V	
	V <sub>IN(1)</sub>	V <sub>DD</sub> = 12V	10.5			
		V <sub>DD</sub> = 5.0V	3.5		1	
Input Resistance	RIN	V <sub>DD</sub> = 12V	35		kΩ	
		V <sub>DD</sub> = 10V	35		1	
		$V_{DD} = 5.0V$	35		1	
Supply Current	I <sub>DD(ON)</sub>	One Driver ON, V <sub>DD</sub> = 12V		5.5	mA	
	, ,	One Driver ON, V <sub>DD</sub> = 10V		4.5	1	
		One Driver ON, V <sub>DD</sub> = 5.0V		3.0	1	
		All Drivers ON, V <sub>DD</sub> = 12V		16	1	
		All Drivers ON, V <sub>DD</sub> = 10V		14	]	
		All Drivers ON, V <sub>DD</sub> = 5.0V		10	]	
	I <sub>DD(OFF)</sub>	All Drivers OFF, V <sub>DD</sub> = 12V		3.5	]	
		All Drivers OFF, V <sub>DD</sub> = 5.0V		2.0	1	

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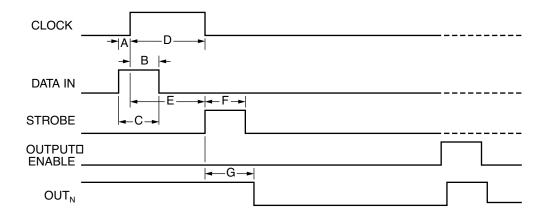
			Limits			
Characteristic	Symbol	Test Conditions	Min.	Max.	Unit	
Output Leakage Current	I <sub>CEX</sub>	V <sub>OUT</sub> = 80V		500	μА	
Collector-Emitter	V <sub>CE(SAT)</sub>	I <sub>OUT</sub> = 100mA		1.3	V	
Saturation Voltage		I <sub>OUT</sub> = 200mA		1.5		
		$I_{OUT} = 350 \text{mA}, V_{DD} = 7.0 \text{V}$		1.8		
Input Voltage	V <sub>IN(0)</sub>			0.8	V	
	V <sub>IN(1)</sub>	V <sub>DD</sub> = 12V	10.5		]	
	. ,	V <sub>DD</sub> = 5.0V	3.5			
Input Resistance	R <sub>IN</sub>	V <sub>DD</sub> = 12V	50		kΩ	
		V <sub>DD</sub> = 10V	50		]	
		V <sub>DD</sub> = 5.0V	50			
Supply Current	I <sub>DD(ON)</sub>	One Driver ON, V <sub>DD</sub> = 12V		4.5	mA	
	, ,	One Driver ON, V <sub>DD</sub> = 10V		3.9	]	
		One Driver ON, V <sub>DD</sub> = 5.0V		2.4	]	
		All Drivers ON, V <sub>DD</sub> = 12V		16	1	
		All Drivers ON, V <sub>DD</sub> = 10V		14	]	
		All Drivers ON, V <sub>DD</sub> = 5.0V		8	1	
	I <sub>DD(OFF)</sub>	All Drivers OFF, V <sub>DD</sub> = 12V		2.9	1	
		All Drivers OFF, V <sub>DD</sub> = 5.0V		1.6	]	

## MIC5821/5822 Family Truth Table

Serial		Shift Register Contents Serial Latch Con				Cont	ents			Output Contents									
Data Input	Clock Input	l <sub>1</sub>	l <sub>2</sub>	l <sub>3</sub>		l <sub>8</sub>	Data Output	Strobe Input	l <sub>1</sub>	l <sub>2</sub>	l <sub>3</sub>		l <sub>8</sub>	Output Enable	l <sub>1</sub>	l <sub>2</sub>	l <sub>3</sub>		l <sub>8</sub>
Н	7	Н	R <sub>1</sub>	R <sub>2</sub>		R <sub>7</sub>	R <sub>7</sub>												
L	7	L	R <sub>1</sub>	$R_2$		R <sub>7</sub>	R <sub>7</sub>												
Х	一	R <sub>1</sub>	R <sub>2</sub>	R <sub>3</sub>		R <sub>8</sub>	R <sub>8</sub>												
		Х	Х	Х		Χ	Х	L	R <sub>1</sub>	R <sub>2</sub>	R <sub>3</sub>		R <sub>8</sub>						
		P <sub>1</sub>	P <sub>2</sub>	P <sub>3</sub>		P <sub>8</sub>	P <sub>8</sub>	Н	P <sub>1</sub>	P <sub>2</sub>	P <sub>3</sub>		P <sub>8</sub>	L	P <sub>1</sub>	P <sub>2</sub>	P <sub>3</sub>		P <sub>8</sub>
									Х	Χ	Χ		Χ	Н	Н	Н	Н		Н

L = Low Logic Level H = High Logic Level X = Irrelevant P = Present State R = Previous State

# **Timing Diagram**



#### **Timing Conditions**

 $(T_A = +25^{\circ}C, Logic Levels are V_{DD} and V_{SS})$ 

		$v_{DD} = 5.0v$
A.	Minimum Data Active Time Before Clock Pulse (Data Set-Up Time)	75 ns
	Minimum Data Active Time After Clock Pulse (Data Hold Time)	
C.	Minimum Data Pulse Width	150 ns
D.	Minimum Clock Pulse Width	150 ns
E.	Minimum Time Between Clock Activation and Strobe	300 ns
F.	Minimum Strobe Pulse Width	100 ns
G.	Typical Time Between Strobe Activation and Output Transition	500 ns

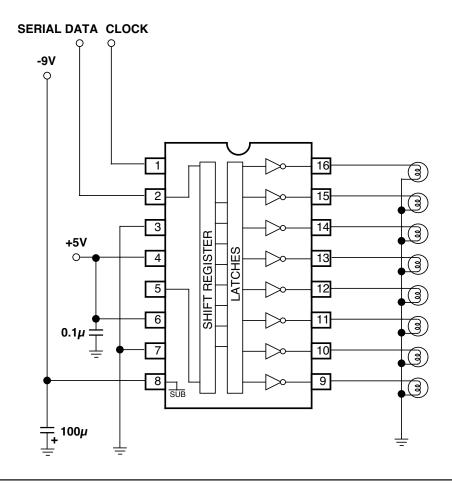
SERIAL DATA present at the input is transferred to the shift register on the logic "0" to logic "1" transition of the CLOCK input pulse. On succeeding CLOCK pulses, the registers shift data information towards the SERIAL DATA OUTPUT. The SERIAL DATA must appear at the input prior to the rising edge of the CLOCK input waveform.

Information present at any register is transferred to its respective latch when the STROBE is high (serial-to-parallel conversion). The latches will continue to accept new data as long as the STROBE is held high. Applications where the latches are bypassed (STROBE tied high) will require that the ENABLE input be high during serial entry.

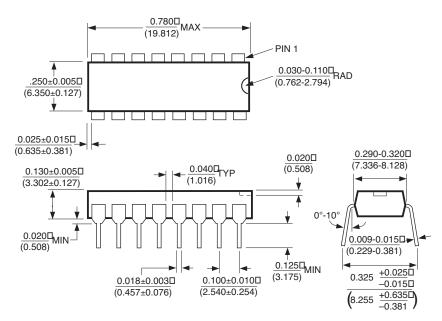
When the ENABLE input is high, all of the output buffers are disabled (OFF) without affecting the information stored in the latches or shift register. With the ENABLE input low, the outputs are controlled by the state of the latches.

#### **Typical Applications**

#### MIC5822 Level Shifting Lamp Driver with Darlington Emitters Tied to a Negative Supply



# **Package Information**



16-Pin Plastic DIP (N)

#### MICREL INC. 2180 FORTUNE DRIVE SAN JOSE, CA 95131 USA

TEL + 1 (408) 944-0800 FAX + 1 (408) 474-1000 WEB http://www.micrel.com

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